## Notice of References Cited

Ī	Application/Control No.	Applicant(s)/Pater	nt Under
	10/564,231	Reexamination WATANABE ET A	AL.
	Examiner	Art Unit	
	ROBERT T. REESE	3657	Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,988,015 A	11-1999	Riu, Herve	74/574.2
*	В	US-2006/0264282 A1	11-2006	Moriya et al.	474/094
*	С	US-7,300,372 B2	11-2007	Riu, Herve	474/94
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
		US-			
	J	US-			
	К	US-			
	L	US-			
	м	US-			

## FOREIGN PATENT DOCUMENTS

FOREIGN FATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2005299909 A	10-2005	Japan	NOMURA, SHUICHI	
	0	JP 2005133917 A	05-2005	Japan	KAKINUMA, YOSHIKAZU	
	Р	JP 2004108528 A	04-2004	Japan	KINOSHITA et al.	
	Q	JP 08177874 A	07-1996	Japan	ULRICH et al.	
	R	EP 1382886 A1	01-2004	European Patent	RIU, HERVE	
	s	WO 2004007992 A1	01-2004	World Intellect	RIU, HERVE	
	Т					

## NON DATENT DOCUMENTS

Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U		
Γ	v		
	w		
	x		

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.